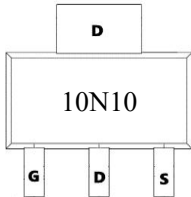
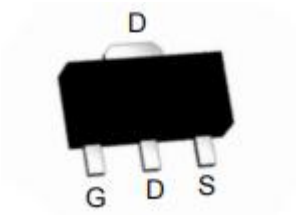
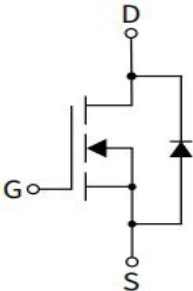


Features ➤ Super Low Gate Charge ➤ Green Device Available ➤ Excellent Cdv/dt effect decline ➤ Advanced high cell density Trench technology	Bvdss	Rdson	ID
	100V	85mΩ	10A
	Application ➤ PWM applications ➤ Load Switch ➤ Power management		



Package		
 Marking and pin assignment	 SOT89-3L top view	 Schematic diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Quantity
10N10	10N10Q	SOT89-3L	1000

Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $V_{GS}@10V^1$	I_D	$T_C=25^{\circ}\text{C}$ 10	A
		$T_C=100^{\circ}\text{C}$ 7	A
Pulsed Drain Current ²	I_{DM}	24	A
Single Pulse Avalanche Energy ³	EAS	6.1	mJ
Avalanche Current	I_{AS}	10	A
Total Power Dissipation ³	P_D	$T_C=25^{\circ}\text{C}$ 34.7	W
		$T_A=25^{\circ}\text{C}$ 2	
Storage Temperature Range	T_{STG}	-55 ~ +150	$^{\circ}\text{C}$
Operating Junction Temperature Range	T_J	-55 ~ +150	$^{\circ}\text{C}$



Thermal Resistance Ratings

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance Junction-ambient ¹	$R_{\theta JA}$	-	62	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	-	3.6	°C/W

Ordering Information

Ordering Number	Package	Pin Assignment			Packing
Halogen Free		G	D	S	
HL10N10Q	SOT89-3L	1	2	3	Tape Reel

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	100	-	-	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=80V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	-	-	1	μA
		$V_{DS}=80V, V_{GS}=0V, T_J=55^{\circ}\text{C}$	-	-	5	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1	-	2.5	V
Static Drain-Source On-Resistance ²	$R_{DS(on)}$	$V_{GS}=10V, I_D=10A$	-	85	112	m Ω
		$V_{GS}=4.5V, I_D=8A$	-	105	120	
Forward Transconductance	g_{fs}	$V_{DS}=5V, I_D=10A$	-	13	-	S
Gate resistance	R_g	$V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$	-	2	-	Ω
Total Gate Charge	Q_g	$V_{GS}=80V, V_{DS}=10V, I_D=10A$	-	26.2	-	nC
Gate-Source Charge	Q_{gs}		-	4.6	-	
Gate-Drain Charge	Q_{gd}		-	5.1	-	
Turn-On Delay Time	$T_{d(on)}$	$V_{DD}=50V, V_{GS}=10V,$ $R_G=3.3\Omega, I_D=10A$	-	4.2	-	ns
Turn-On Rise Time	T_r		-	8.2	-	
Turn-Off Delay Time	$T_{d(off)}$		-	35.6	-	
Turn-Off Fall Time	T_f		-	9.6	-	
Input Capacitance	C_{iss}	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$	-	1535	-	pF
Output Capacitance	C_{oss}		-	60	-	
Reverse Transfer Capacitance	C_{rss}		-	37	-	
Continuous Source Current ^{1,5}	I_S	$V_G=V_D=0, \text{Force Current}$	-	-	10	A
Pulsed Source Current ^{2,5}	I_{SM}		-	-	20	A
Diode Forward Voltage ²	V_{SD}	$V_{GS}=0V, I_S=1A, T_J=25^{\circ}\text{C}$	-	-	1.2	V



Reverse Recovery Time	t_{rr}	IF=10A, di/dt=100A/μs, T _J =25°C	-	37	-	nS
Reverse Recovery Charge	Q_{rr}		-	27.3	-	nC

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3.The EAS data shows Max. rating . The test condition is V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=11A.
- 4.The power dissipation is limited by 150°C junction temperature.
- 5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Typical Performance Characteristics

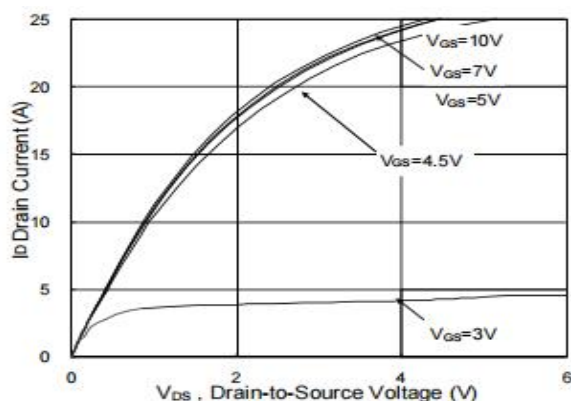


Fig.1 Typical Output Characteristics

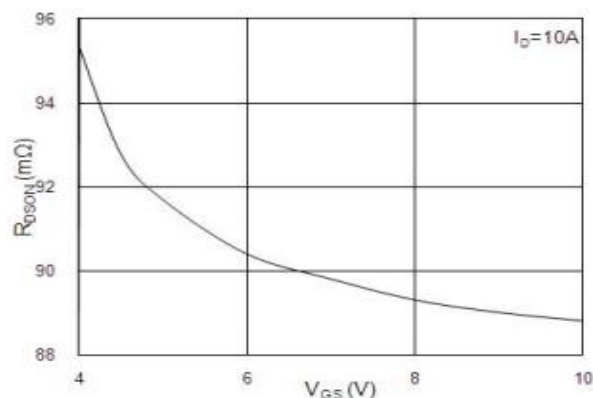


Fig.2 On-Resistance vs. Gate-Source

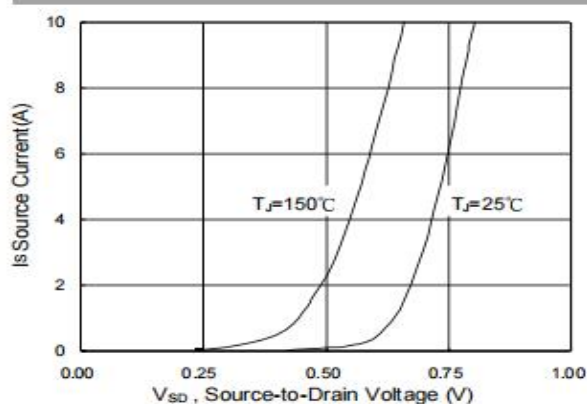


Fig.3 Forward Characteristics Of Reverse

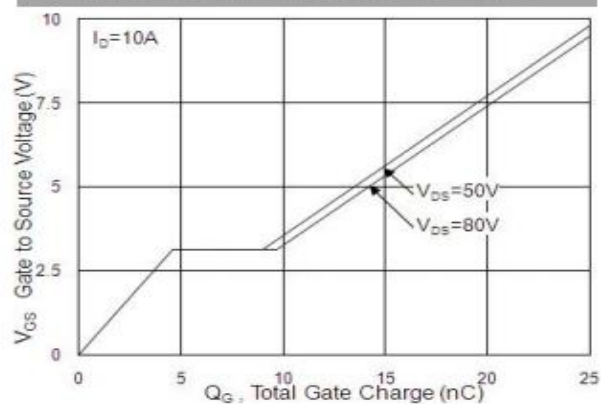


Fig.4 Gate-Charge Characteristics

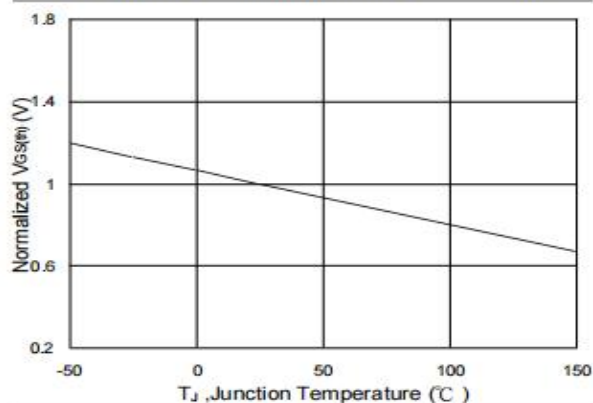


Fig.5 Normalized V_{GS(th)} vs. T_J

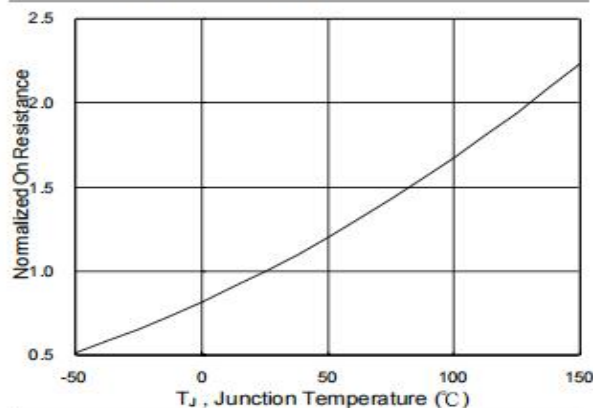


Fig.6 Normalized R_{DS(on)} vs. T_J

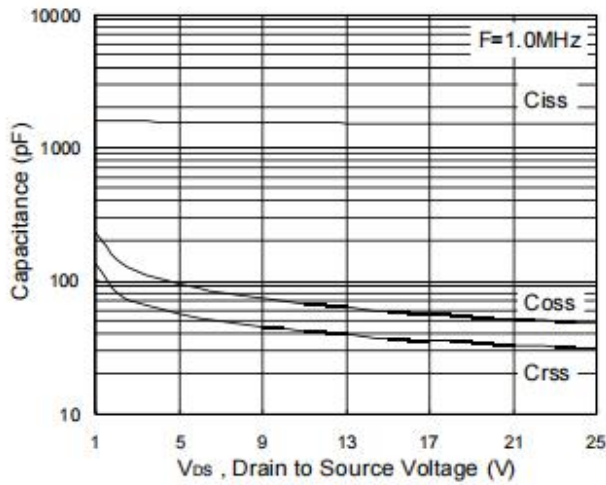


Fig.7 Capacitance

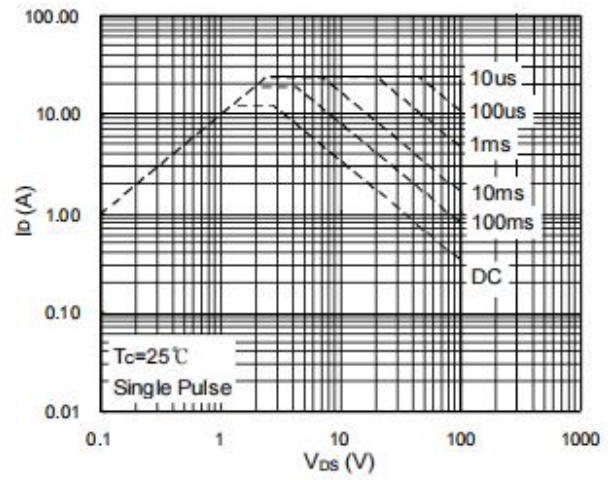


Fig.8 Safe Operating Area

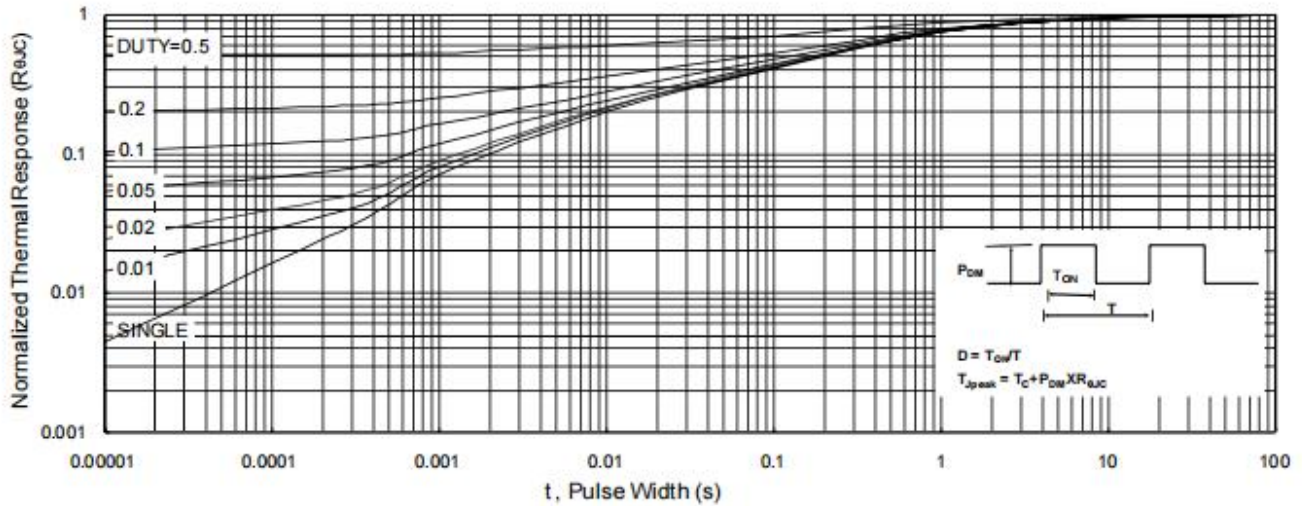


Fig.9 Normalized Maximum Transient Thermal Impedance

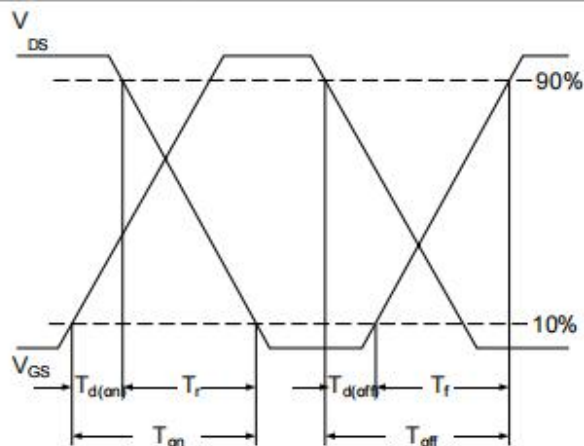


Fig.10 Switching Time Waveform

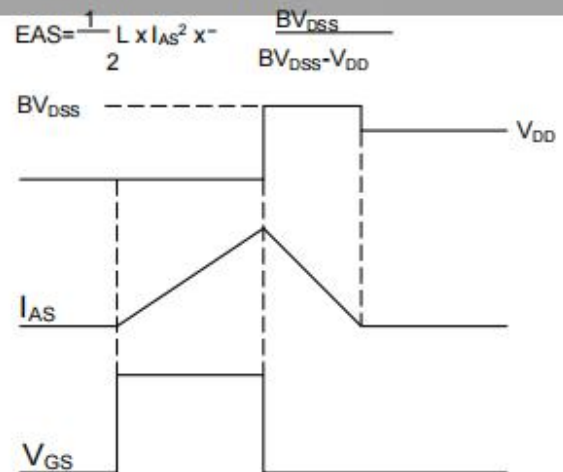
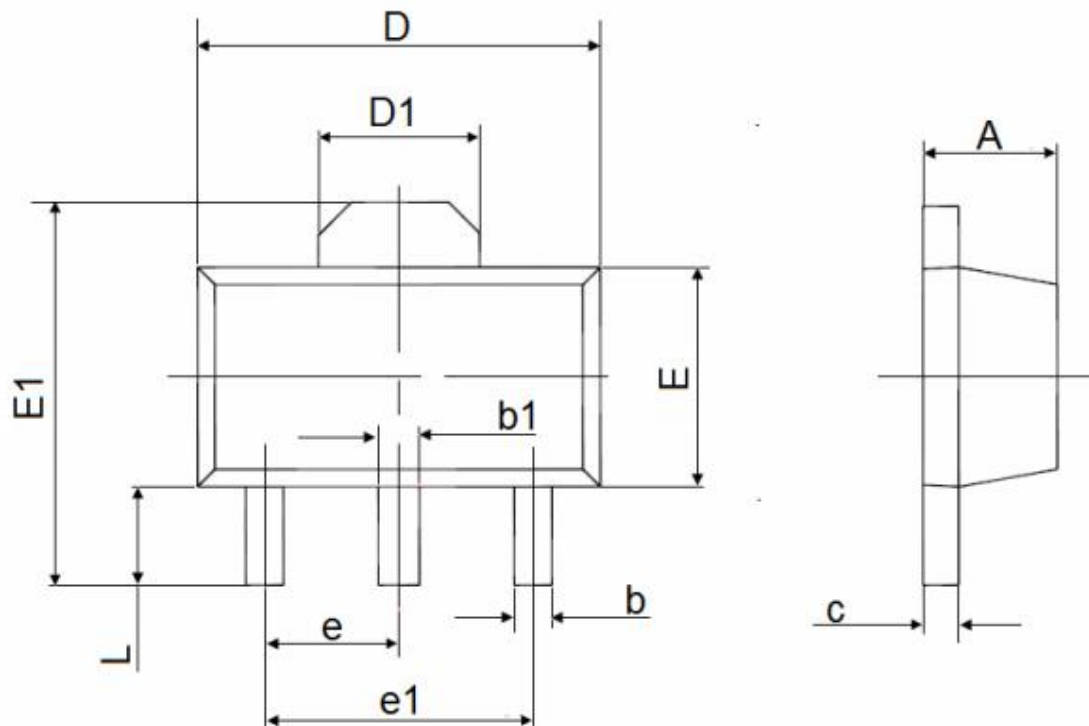


Fig.11 Unclamped Inductive Switching Waveform

Package Dimensions SOT89-3L


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.400	1.600	0.055	0.063
b	0.320	0.520	0.013	0.020
b1	0.400	0.580	0.016	0.023
c	0.350	0.440	0.014	0.017
D	4.400	4.600	0.173	0.181
D1	1.550 REF.		0.061 REF.	
E	2.300	2.600	0.091	0.102
E1	3.940	4.250	0.155	0.167
e	1.500 TYP.		0.060 TYP.	
e1	3.000 TYP.		0.118 TYP.	
L	0.900	1.200	0.035	0.047

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